

3N120-E3

Preliminary

## 3.0A, 1200V N-CHANNEL POWER MOSFET

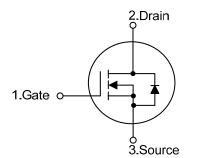
## DESCRIPTION

The UTC **3N120-E3** provide excellent  $R_{DS(ON)}$ , low gate charge and operation with low gate voltages. This device is suitable for use as a load switch or in PWM applications.

## FEATURES0

- \*  $R_{DS(ON)} \le 7.0 \ \Omega \ @ V_{GS}=10V, I_D=1.5A$
- \* Low Reverse Transfer Capacitance
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness

## SYMBOL

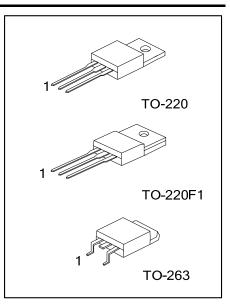


## ORDERING INFORMATION

Ordering Number		Deelverie	Pin Assignment			Deaking
Lead Free	Halogen Free	Package	1	2	3	Packing
3N120L-TA3-T	3N120G-TA3-T	TO-220	G	D	S	Tube
3N120L-TF1-T	3N120G-TF1-T	TO-220F1	G	D	S	Tube
3N120L-TQ2-T	3N120G-TQ2-T	TO-263	G	D	S	Tube
3N120L-TQ2-R	3N120G-TQ2-R	TO-263	G	D	S	Tape Reel

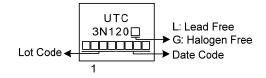
Note: Pin Assignment: G: Gate D: Drain S: Source

3N120G-TA3-T	(1)Packing Type	(1) T: Tube, R: Tape Reel
	(2)Package Type	(2) TA3: TO-220, TF1: TO-220F1, TQ2: TO-263
	(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free



# 3N120-E3

## MARKING





#### ■ ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	1200	V
Gate-Source Voltage		V <sub>GSS</sub>	±30	V
	Continuous	ID	3	А
Drain Current	Pulsed (Note 2)	I <sub>DM</sub>	6	А
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	75	mJ
Peak Diode Recovery dv/d	Peak Diode Recovery dv/dt (Note 4)		2.9	V/ns
	TO-220/TO-263	D	68	W
Power Dissipation	TO-220F1	PD	18	W
Junction Temperature		TJ	+150	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 30mH,  $I_{AS}$  = 2.25A,  $V_{DD}$  = 100V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C.

4. I\_{SD} \leq 3.0A, di/dt  $\leq$  200A/µs, V\_{DD}  $\leq$  BV\_{DSS}, Starting T\_J = 25°C.

#### THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient		θ <sub>JA</sub>	62.5	°C/W
Junction to Case	TO-220/TO-263	0	1.83	°C/W
	TO-220F1	θις	6.94	°C/W



#### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub> =25°C, unless otherwise specified)

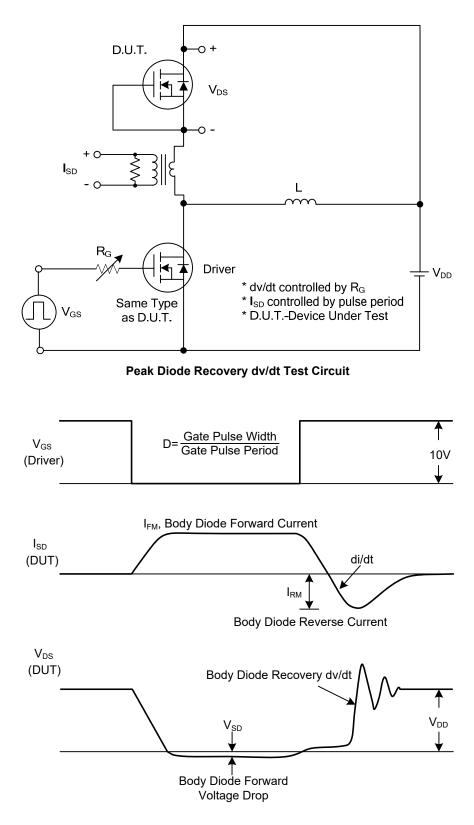
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TVD	ΜΔΥ		
PARAMETER SYMBOL TEST CONDITIONS   MIN   TYP   MAX   UN OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	1200			V	
Drain-Source Leakage Current		V <sub>GS</sub> =0V, I <sub>D</sub> =250µA V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V			10	ν μΑ	
	IDSS						
Gate-Source Leakage Current	IGSS	$V_{GS}$ =±30V, $V_{DS}$ =0V			±100	nA	
ON CHARACTERISTICS	) (		3.0		5.0	V	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA			5.0	V	
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =1.5A			7.0	Ω	
DYNAMIC CHARACTERISTICS		I					
Input Capacitance	CISS	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz		570		рF	
Output Capacitance	Coss			60		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>			13		рF	
SWITCHING CHARACTERISTICS			-				
Total Gate Charge (Note 1)	$Q_{G}$	−V <sub>DS</sub> =960V, V <sub>GS</sub> =10V, I <sub>D</sub> =3.0A − −(Note 1, 2)		28		nC	
Gate-Source Charge	Q <sub>GS</sub>			12		nC	
Gate-Drain Charge	$Q_{GD}$			10		nC	
Turn-On Delay Time (Note 1)	t <sub>D(ON)</sub>	V <sub>DD</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =3.0A, R <sub>G</sub> =25Ω (Note 1, 2)		11		ns	
Turn-On Rise Time	t <sub>R</sub>			20		ns	
Turn-Off Delay Time	t <sub>D(OFF)</sub>			69		ns	
Turn-Off Fall Time	t⊧			43		ns	
SOURCE- DRAIN DIODE RATINGS AND CH	ARACTERISTI	CS					
Maximum Continuous Drain-Source Diode					•	•	
Forward Current	ls				3	A	
Maximum Pulsed Drain-Source Diode	I				6		
Forward Current	I <sub>SM</sub>				6	A	
Drain-Source Diode Forward Voltage (Note 1)	V <sub>SD</sub>	I <sub>S</sub> =3.0A, V <sub>GS</sub> =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	Is=3.0A, V <sub>GS</sub> =0V,		780		nS	
Body Diode Reverse Recovery Charge	Qrr	dl⊧/dt=100A/µs		5.07		μC	
Natara 4 Dulas Tast Dulas width < 00000 Du	h	· ·					

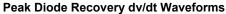
Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%.

2. Essentially independent of operating temperature.



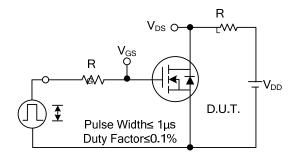
## TEST CIRCUITS AND WAVEFORMS



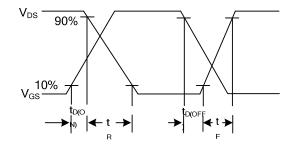


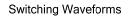


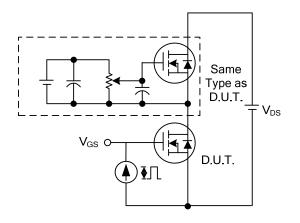
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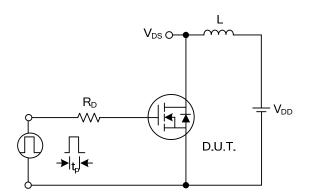
Switching Test Circuit



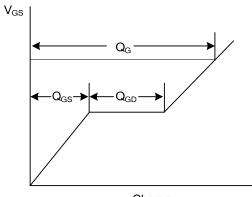






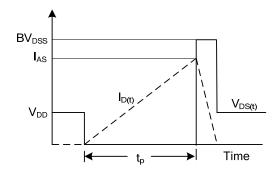


Unclamped Inductive Switching Test Circuit



Charge

Gate Charge Waveform



Unclamped Inductive Switching Waveforms



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